

## BEST AVAILABLE COPY

Sheet 1 of 2

0-1449

U.S. DEPARTMENT OF  
COMMERCE  
PATENT AND TRADEMARK  
OFFICEATTY. DOCKET NO.  
45532/1:7APPLICATION NO.  
10/053,483

-80)

JUN 05 2002

APPLICANT

Ronald A. Palfenier et al.

## INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

FILING DATE  
November 2, 2001

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WF	AA	6	0	0	7	2	4	1	Dec 1999	Yam et al.	374	131	
WF	AB	5	8	9	7	6	1	0	Apr 1999	Jensen	702	134	
WF	AC	5	8	1	5	4	1	0	Sep 1998	Heinke et al.	364	557	
WF	AD	5	7	1	7	6	0	8	Feb 1998	Jensen	364	557	
WF	AE	5	7	0	4	7	1	2	Jan 1998	Stein	374	126	
WF	AF	5	6	9	0	4	2	9	Nov 1997	Ng	374	1	
WF	AG	5	1	5	4	5	1	2	Oct 1992	Scheitinger et al.	374	9	
WF	AH	4	9	5	6	5	3	8	Sep 1990	Moslehi	219	121.6	
WF	AI	4	8	4	5	6	4	7	Jul 1989	Dils et al.	364	557	
WF	AJ	4	7	5	0	1	3	9	Jun 1988	Dils	364	557	
WF	AK	4	5	7	4	4	8	6	Mar 1986	Dils	374	131	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

WF	AR	"Optical Pyrometry Begins to Fulfill its Promise," Alexander Braun, Semiconductor International, March 1998, pp. 1 and 2.
WF	AS	"A New Detector for IRLED Light," Russ Dahl and Michael Allen, reprinted from SENSORS Magazine, December 1996, 4 pp.
	AT	

EXAMINER

Demetris Petros

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EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DP	AA	4	3	4	8	1	1	0	Sep 1982	Ito	356	328		
DP	AB	4	0	7	5	4	9	3	Feb 1978	Wickersheim	250	461 R		
DP	AC	3	6	2	6	7	5	8	Dec 1971	Stewart et al.	73	355R		
DP	AD	2	7	0	9	3	6	7	May 1955	Bohnet	73	355		
DP	AE	1	6	3	9	5	3	4	Aug 1927	Ruben				
DP	AF	1	4	7	5	3	6	5	Nov 1923	Schueler et al.				
	AG													
	AH													
	AI													
	AJ													
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EXAMINER

*Dennis Palfenier*

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